

PRESS RELEASE

09 | 23

PRESS RELEASE

May 4, 2023 | page 1 / 5

HotSense – new thin-film measurement techniques for high-vacuum and high-temperature processes

In cooperation with SURAGUS GmbH, the Fraunhofer Institute for Organic Electronics, Electron Beam and Plasma Technology FEP has succeeded in realizing non-contact in-situ measurements under high vacuum conditions at temperatures of up to 220°C within the HotSense project (grant number 100547507/4102) funded by the Saxon State Ministry of Economics, Labor and Transport (SMWA). Thus, measurements of the sheet resistance or -conductivity, or the metal layer thickness can be carried out in close proximity to the process directly after hot layer deposition or layer modification processes by means of non-contact high-frequency eddy current measurement. Furthermore, the developed setup can be adopted for process characterization up to 450 to 600 degrees Celsius. The results will be presented in a poster at SVC Techcon, May 8 – 11, 2023, in Washington D.C, USA.

Thin, functional conductive layers with adjustable properties are not always obvious, but occur in a wide range of applications. These include, for example, switchable or energy-efficient windows, various types of solar cells, batteries, semiconductor chips (ICs) as well as touch screens. With their adapted properties, the very thin functional layers are essential for the functionality, lifetime and performance of these applications. The coating processes for depositing such thin films usually take place in high vacuum and in case of transparent conductive layers under high process temperatures.

Annealing processes for the specific adjustment of coating and/or substrate properties also require several hundred degrees Celsius. Direct measurements of the sheet resistance are typically used for process control and stabilization. Previous measurement methods for non-contact electrical in-situ characterization of such vacuum coatings are only possible up to a temperature of 65°C, which prevents efficient plant operation. This limit has now been significantly extended so that in-situ coating characterization can now be carried out directly in the high-temperature process environment or even close to the process and without any sample contact.

Fraunhofer FEP has extensive experience and comprehensive know-how in the field of surface engineering for stationary and sheet-to-sheet as well as roll-to-roll processes. To ensure high quality and functionality of the customized coating stacks, characterization and monitoring of the process steps in-situ, i.e. during the coating processes, is necessary. Especially in vacuum processes, compatible real-time measurements – for example





Funded by: Saxon State Ministry for Economy, Labor and Transport Funding reference: 100547507/4102



of sheet resistance – are challenging but necessary to enable contamination-free and reproducible results.

SURAGUS GmbH is a specialist for non-contact coating and material characterization by means of high-frequency eddy current sensor technology. The company, located in Dresden, employs approximately 50 people and is continuously expanding the fields of application for applied inductive measurement technology.

09 | 23

PRESS RELEASE

May 4, 2023 | page 2 / 5

Development of new in-situ measurement methods for high process temperatures

The project HotSense funded by the Saxon State Ministry of Economics, Labor and Transport aims to close this gap. For this purpose, the project partners SURAGUS and Fraunhofer FEP investigated measurement methods for the non-contact in-situ characterization of the electrical resistance of thin films under high vacuum and high temperature requirements.

After two years of joint development, the researchers have succeeded in implementing the measurement method at elevated temperatures of up to 220°C, which means that coating characterization is also possible at elevated process temperatures.

The sheet resistance is measured in direct vicinity of the processes under vacuum conditions in order to give immediate feedback for coating processes and to avoid oxidation during annealing. In addition, the measuring head was significantly reduced in size in the test setup, which enables applications with limited installation space.

With this non-contact measurement method for monitoring heated coating or annealing processes, customers can optimize their processes, quality and the operating costs of equipment. This enables measurements in many other applications and plant types.

Application-oriented measurement setup with downsized sensor head

Project manager Thomas Preußner from Fraunhofer FEP explains: "Together, we created a measurement setup under conditions close to the application. Fraunhofer FEP was able to draw on its extensive knowledge of the resistance-temperature behavior of thin films up to 600°C. Using the results from the correlation between temperature and measurement signal, SURAGUS developed a novel measurement compensation algorithm ensuring precise resistivity values. We also supported the experimental setup with our knowledge of the influence of crystallization and phase changes of transparent conductive oxides (TCOs) during the annealing process."



The developers at SURAGUS contributed extensive knowledge about the behavior of the measurement setup and the sensor. In the course of the developments, the sensor head for the characterization was redesigned and, with a size of approx. $12 \times 40 \text{ mm}^2$, got significantly smaller. The entire measurement setup was tested and developed at the ILA 900 in-line sputtering system for coating flat substrates, under clean room conditions, at Fraunhofer FEP.

As a result, the new measurement setup could be investigated and characterized on a pilot scale. Metrological investigations were carried out on drift, signal strength, external sources of interference and the behavior of sensor, sample and temperature in relation to each other. Specifically, the resistance measurement range extends over three decades and exhibits a reproducibility < 2%. The solution aimed at here will cover five measurement decades from 0.001 to 100 Ohm/sq, which includes a metal thickness measurement range from a few nanometers to a few micrometers.

The first commercial systems are planned to be launched on the market by SURAGUS by the end of 2023. Together with SURAGUS, Fraunhofer FEP aims to further develop the existing technology to enable characterization at even higher temperatures. Both project partners are open for customer-specific investigations

The project results will be presented at the 66th SVC TechCon 2023, May 8-11, 2023 in Washington D.C., USA, in conference presentations and at the Fraunhofer FEP booth.

About the HotSense project

Investigation of the measurement method for the contactless in-situ characterization of the electrical resistance of thin films under high vacuum and high temperature conditions (HotSense)

Funded by: Saxon State Ministry for Economy, Labor and Transport

Funding reference: 100547507/4102 Duration: 01.06.2021 – 31.11.2022

Fraunhofer FEP at SVC Techcon 2023

May 8 – 11, 2023 Washington D.C., USA Booth no. 722

https://svctechcon.com

09 | 23

PRESS RELEASE

May 4, 2023 | page 3 / 5



Conference contributions

Vacuum Deposition of an Aluminum Alloy with 1 μ m/s on Different Types of Semi-Finished Products Dr. Jens-Peter Heinß May 8, 2023, 12:30 pm, Tribo (TT5)

Investigation of Heat Load to Substrates during Electron Beam Physical Vapor Deposition Processes and Comparison to Magnetron Sputtering Dr. Stefan Saager May 8, 2023, 04:50 pm, E-Beam (EB2)

Invited Talk: "From Lab to Pilot – Bridging the Gap from Feasibility to Scalability for Surface Engineering Solutions"
Dr. Jörg Neidhardt
May 10, 2023, 11:50 am, Large Area (LTimv1)

Synthesis of Magnetic Particles for Printable Inks and Pastes by Sputtering for Sensor Applications
Morris Ott
May 11, 2023, 04:10 pm, Sensors (SE2)

Poster

Eddy Current Monitoring in High Temperature Vacuum Environment Thomas Preußner, Marcus Klein et al.

Further publications on the topic

Dünnschichttechnologien für die Energiewende Fahland, Matthias et al.; Galvanotechnik; 2023

High-rate sputter etching of substrates using hollow-cathode arc-discharge sources Heinß, Jens-Peter; Klose, Lars; SVC Bulletin; 2023

Multi-Source-CT for inline inspection of extruded profiles Rettenberger, Simon et al.; NDT.net; 2023

09 | 23

PRESS RELEASE

May 4, 2023 | page 4 / 5



09

23

PRESS RELEASE

May 4, 2023 | page 5 / 5



Newly developed measurement setup with sensor measuring head for in-situ characterization of coating processes at high process temperatures

© Fraunhofer FEP

Picture in printable resolution: www.fep.fraunhofer.de/press



Newly developed measurement setup with sensor measuring head for in-situ characterization of coating processes at high process temperatures

© Fraunhofer FEP

Picture in printable resolution: www.fep.fraunhofer.de/press



ILA 900 – Vertical in-line sputtering system for coating flat substrates, under clean room conditions with a magnetron length of 900 mm

© Fraunhofer FEP

Picture in printable resolution: www.fep.fraunhofer.de/press

The **Fraunhofer Institute for Organic Electronics, Electron Beam and Plasma Technology FEP** works on innovative solutions in the fields of vacuum coating, surface treatment as well as organic semiconductors. The core competencies electron beam technologies, roll-to-roll technology, plasma-activated large-area and precision coating as well as technologies for organic electronics and IC design provide a basis for these activities. Thus, Fraunhofer FEP offers a wide range of possibilities for research, development and pilot production, especially for the processing, sterilization, structuring and refining of surfaces as well as OLED microdisplays, organic and inorganic sensors as well as optical filters. Our aim is to seize the innovation potential of the electron beam, plasma technology and organic electronics for new production processes and devices and to make it available for our customers.